Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/797,071	GOODWILL ET AL.		
Examiner	Art Unit		
Sang Nguyen	2877		

	SEAR	CHED	
Class	Subclass	Date	Examiner
UP DATE	searched the same on 4/20/06	9/30/2006	SN
250	214 A	1	1
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359	341	U_	
356	218, 73	9/30/2006	SN

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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